Notice of References Cited

Application/Control No.
09/963,815
Examiner

Applicant(s)/Patent Under Reexamination BENJEY, ROBERT P.

Examiner Art Unit
John Rivell 3753

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,282,497	02-1994	Allison, Allen	141/59
	В	US-5,054,528	10-1991	Saitoh, Shirou	141/59
	С	US-5,205,330	04-1993	Sekine, Hidetoshi	141/59
	D	US-5,570,672	11-1996	Kunimitsu et al.	123/516
	Е	US-5,579,742	12-1996	Yamazaki et al.	123/520
	F	US-5,596,971	01-1997	Kidokoro, Toru	123/516
	G	US-5,657,734	08-1997	Sawamoto et al.	123/519
	Н	US-5,769,057	06-1998	Hashimoto et al.	123/516
	ī	US-5,819,796	10-1998	Kunimitsu et al.	137/587
	J	US-5,870,997	02-1999	Mukai, Takeshi	123/520
	к	US-6,000,426	12-1999	Tuckey et al.	137/588
	L	US-6,170,538	01-2001	Devall, Jeffrey	141/59
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ρ					
	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.